RSD-60 Rotary Device



Rotary Kit Contents

RSD-60 Rotary Device Faceplate with Hardened Finish (Ti-Al-N) Three-Jaw Chuck with Faceplate Adapter Calibration Artifact and 45° Mirror Assembly Stage Mounting Bracket Vertical Mounting Bracket Cables, Cable Guide, and Routing Brackets Tools, Mounting Hardware, & Cases

Applications

Bits and Cutters Medical and Dental Parts Multi-Sided Part Automation Swiss Screw Parts Valves and Fittings

Advanced Features and Functions

Horizontal and Vertical Mounting Capability Intuitive On-Screen Joystick Interface Seamless Software Integration Rotate to Position Relative to Current Position Rotate to Position Relative to a Coordinate System Rotate to Position Based on Measurements Automated Rotary Calibration Non-Linear Calibration Saved to On-Board Memory Ready to Mount on Micro-Vu Vertex and Excel Systems

RSD-60 Rotary Device Specifications

External Dimensions Centerline Height Maximum Speed Resolution Accuracy On Axis Capacity Chuck Thread Weight 95x150x80 mm 60 mm 120°/second 1.3 Arc Seconds +/- 15 Arc Seconds 1.5 Nm M14 x 1.0 1.5 kg

Micro-Vu Corporation

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(937) 436-4699 sales@rfminc.net www.rfminc.net

www.microvu.com

Jouch Probe **Kits**

Integrate Vision and Touch Measurements Vertex and Excel Systems are Probe-Ready **Designed with Kinematic Fixture Mounts**

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Touch Probe Kit Contents

RENISHAW TP20 Probe Body RENISHAW TP20 Probe Modules (2 ea.) M2 Five Way Stylus Center M2 Stylus (5 ea. 3 mm x 20mm) M2 Extensions (2 ea. 10 mm, 2 ea. 20 mm, & 1 ea. 30 mm) Multi-Port Probe Change Rack (2 or 4 Port) Module, Stylus, and Fixture Storage Box Micro-Vu Offset Fixture & Reference Sphere Assembly Instructions, Tools, Mounting Hardware, Cleaning Kit, & Case



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InSpec's Advanced Touch Probe Functions

Intuitive Probe Assembly Interface Automated Docking in Multi-Port Probe Change Rack Automated Probe Tip Qualification Including Lobing Automated Z Scale and Perpendicularity Calibration Automatic Approach Vectoring and Solution Iteration Automatic Retract and Adjustable Standoff Distances FREE InSpec 2.XX Updates - No Maintenance Fees